

ICS 31.080.10

CCS L 41



**NATIONAL STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

GB/T 6589-2002

Replacing GB/T 6589-1986

**Semiconductor devices -- Discrete devices -- Part 3-2: Signal (including switching) and
regulator diodes -- Blank detail specification for voltage-regulator diodes and
voltage-reference diodes (excluding temperature-compensated precision reference
diodes)**

(English Translation)

Issued on: December 4, 2002

Implemented on: May 1, 2003

**Issued by: General Administration of Quality Supervision, Inspection and
Quarantine of the People Republic of China**

Table of Contents

What this standard covers	1
Document data	2

What this standard covers

This standard defines the quality assessment procedures, in such a way that a participating State clearance by the relevant regulatory requirements without further testing of electronic components in all other participating countries and is equally acceptable. IEC quality assessment system for electronic components according to IEC charter and work under the authority of the IEC.

Document data

International classification (ICS): 31.080.10.

Chinese classification (CCS): L41.

Estimated length of the Chinese original: 14,132 words.

Adopted international standard: IEC 60747-3-2-1986 (QC 750005), IDT.

Supersedes the earlier edition GB/T 6589-1986.